Special Issue

Safety, Efficiency, and Reliability of Connected Smart Sensor Systems

Message from the Guest Editor

The aim of this Special Issue is to gather the latest contributions from academia and industry focused on addressing these key challenges for improving the safety, security, efficiency, and reliability of connected smart sensor systems. Review papers on emerging technologies and applications of novel connected smart sensor systems are welcome. The topics of interest include but are not limited to the following:

- Network protocols for connected smart sensor systems;
- Security, robustness, and reliability of connected smart sensor systems;
- Energy efficiency for connected smart sensor systems;
- Foundations and theory for connected smart sensor systems;
- Edge and fog computing for connected smart sensor systems;
- Embedded system architecture for connected smart sensor systems;
- Deployment experiences;
- Test-bed development experiences:
- Machine learning analytics for connected smart sensor systems;
- Big data management for connected smart sensor systems;
- Data mining for connected smart sensor systems;
- Human-in-the-loop aspects of connected smart sensor systems;
- Applications of connected smart sensor systems.

Guest Editor

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Deadline for manuscript submissions

closed (28 February 2022)



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About the Journal

Message from the Editor-in-Chief

Electronics is a multidisciplinary journal designed to appeal to a diverse audience of research scientists, practitioners, and developers in academia and industry. The journal is devoted to fast publication of latest technological breakthroughs, cutting-edge developments, and timely reviews of current and emerging technologies related to the broad field of electronics. Experimental and theoretical results are published as regular peer-reviewed articles or as articles within Special Issues guestedited by leading experts in selected topics of interest.

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manuscripts are peer-reviewed and a first decision is provided to authors approximately 16.8 days after submission; acceptance to publication is undertaken in 2.4 days (median values for papers published in this journal in the first half of 2025).

